

<b>Notice of References Cited</b>	Application/Control No. 10/784,327	Applicant(s)/Patent Under Reexamination BURDENKO, MICHAEL N.	
	Examiner Huan H. Tran	Art Unit 2861	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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**FOREIGN PATENT DOCUMENTS**

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	N	JP 56-157389	12-1981	Japan	Yabuki et al	B41J011/02
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